

MOSFET - Power, Single N-Channel, LFPAK8 30 V, 0.65 mΩ, 410 A

NTMJS0D7N03CG

Features

- Wide SOA to Improve Inrush Current Management
- Advanced LFPAK Package (5x6mm) with Excellent Thermal Conduction
- Ultra Low R_{DS(on)} to Improve System Efficiency
- These Devices are Pb–Free, Halogen/BFR–Free and are RoHS Compliant

Typical Applications

- Hot Swap Application
- Motor Drive
- Power Load Switch
- Battery Management

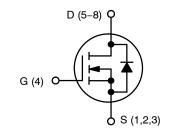
MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	30	V
Gate-to-Source Voltage			V_{GS}	±20	V
Continuous Drain		T _C = 25°C	I _D	410	Α
Current R _{θJC} (Note 1)	Steady	T _C = 100°C	1	290	
Power Dissipation R _{θJC} (Note 1)	State	T _C = 25°C	P _D	188	W
Continuous Drain Current R _{0JA} (Notes 1, 2)	Steady	T _A = 25°C	I _D	59	Α
		T _A = 100°C		42	
Power Dissipation R _{θJA} (Notes 1, 2)	State	T _A = 25°C	P _D	4.0	W
Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 μs	I _{DM}	900	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 40.8 A)			E _{AS}	1080	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using a 1 in2, 2 oz. Cu pad.
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

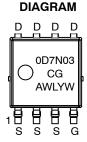
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	0.65 m Ω @ 10 V	410 A



N-CHANNEL MOSFET



CASE 760AA



MARKING

0D7N03CG = Specific Device Code

A = Assembly Location

WL = Wafer Lot Y = Year W = Work Week

ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 5 of this data sheet.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 1)	$R_{ heta JC}$	0.8	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{ heta JA}$	38	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	134	

Parameter	Symbol	bol Test Condition			Тур	Max	Unit
OFF CHARACTERISTICS	•						
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /	I _D = 250 μA, ref to 25°C			11		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$			1.0	μA
		V _{DS} = 30 V	T _J = 125°C			100	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V				100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 280 \mu A$		1.3		2.2	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J	I _D = 280 μA, ref to 25°C			-5.1		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		0.55	0.65	mΩ
Forward Transconductance	9FS	V _{DS} = 3 V, I _D = 30 A			100		S
Gate Resistance	R _G	T _A = 25°C			0.4		Ω
CHARGES & CAPACITANCES							
Input Capacitance	C _{ISS}	V _{GS} = 0 V, V _{DS} = 15 V, f = 1 MHz			12300		pF
Output Capacitance	C _{OSS}				5800		
Reverse Transfer Capacitance	C _{RSS}				88		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V; I _D = 30 A			147		nC
Threshold Gate Charge	Q _{G(TH)}				19		
Gate-to-Drain Charge	Q_{GD}				8.6		
Gate-to-Source Charge	Q_{GS}				34		1
SWITCHING CHARACTERISTICS (Note	4)						
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 30 A, R_{G} = 3 Ω			28		ns
Rise Time	t _r				13		
Turn-Off Delay Time	t _{d(OFF)}				85		
Fall Time	t _f				16		
DRAIN-SOURCE DIODE CHARACTERIS	STICS						•
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		0.78	1.2	
	I _S = 30 A T _J = 125°C	0.62		· V			
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, V _R = 15 V, I _S = 30 A, dIS/dt = 100 A/μs			98		ns
Reverse Recovery Charge	Q _{RR}				143		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

4. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

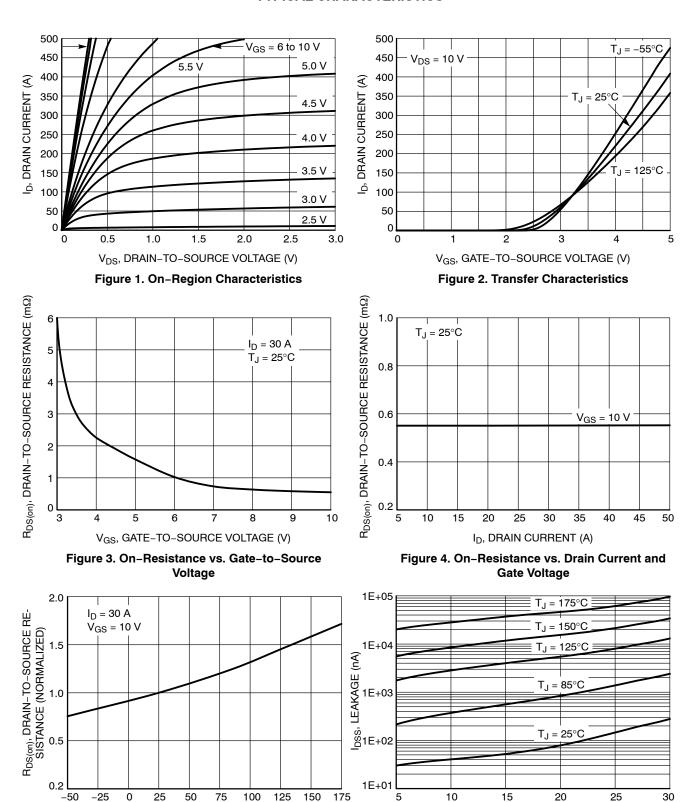


Figure 5. On–Resistance Variation with Temperature

T_J, JUNCTION TEMPERATURE (°C)

Figure 6. Drain-to-Source Leakage Current vs. Voltage

V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

TYPICAL CHARACTERISTICS

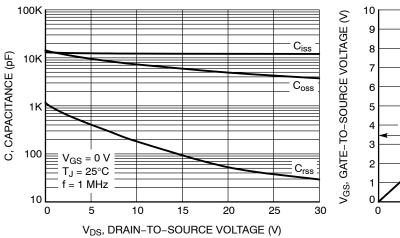


Figure 7. Capacitance Variation

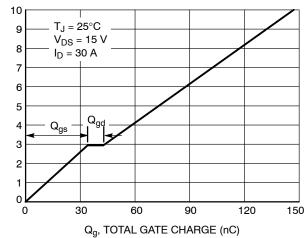


Figure 8. Gate-to-Source vs. Total Charge

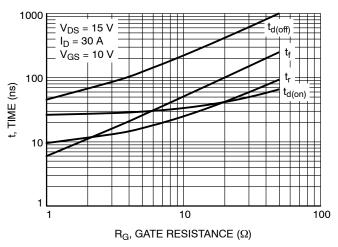


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

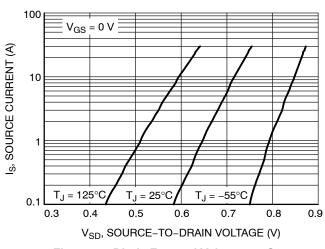


Figure 10. Diode Forward Voltage vs. Current

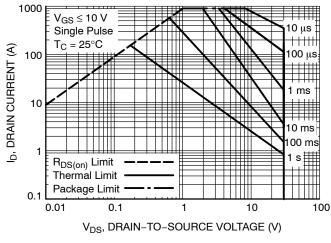


Figure 11. Maximum Rated Forward Biased Safe Operating Area

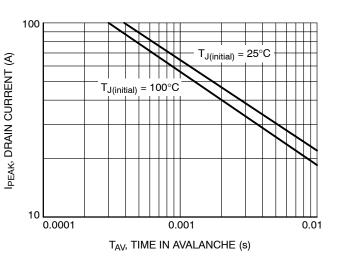


Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS

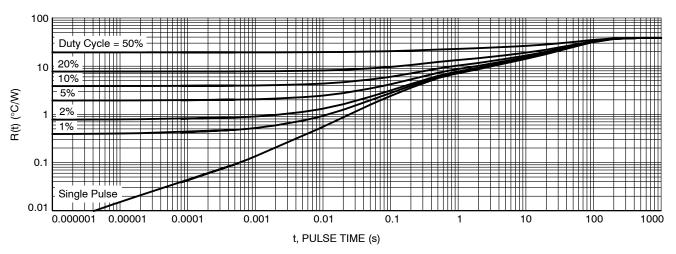


Figure 13. Thermal Response

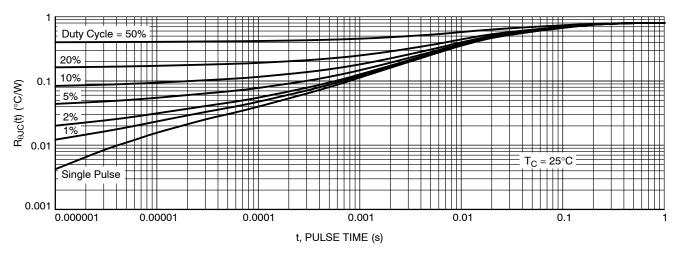


Figure 14. Thermal Response

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NTMJS0D7N03CGTWG	0D7N03 CG	LFPAK8 (Pb-Free)	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





LFPAK8 4.90x4.80x1.12MM, **1.27P**CASE 760AA ISSUE D

DATE 22 APR 2024





NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2018.
- CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- 4. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 5. OPTIONAL MOLD FEATURE.









RECOMMENDED LAND PAD

*FOR ADDITIONAL INFORMATION ON OUR

MANUAL, SOLDERRM/D.

PB-FREE STRATEGY AND SOLDERING DETAILS.

PLEASE DOWNLOAD THE ONSEMI SOLDERING AND MOUNTING TECHNIQUES REFERENCE

MILLIMETERS MIN NOM DIM 1.10 1.20 1.30 Α A1 0.00 0.08 0.15 Α2 1.10 1.15 1.20 АЗ 0.25 BSC b 0.40 0.45 0.50 0.45 0.55 0.65 b4 0.19 0.22 0.25 С c2 0.19 0.22 0.25 4.70 4.80 4.90 D D1 3.80 4.00 4.20 2.98 D2 3.08 3.18 D3 0.30 0.40 0.50 D4 0.55 0.65 0.75 4.80 4.90 5.00 Ε E1 5.05 5.15 5.25 E2 3.91 3.96 4.01 1.27 BSC е 0.635 BSC e/2 Н 6.00 6.15 6.30 L 0.50 0.70 0.90 0.25 0.35 L1 0.15 L2 1.10 REF 4° θ

GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

= Work Week

A = Assembly Location

WL = Wafer Lot Y = Year

W

*This information is generic. Please refer to device data sheet for actual part marking. Some products may not follow the Generic Marking.

DOCUMENT NUMBER:

98AON82475G

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DESCRIPTION:

LFPAK8 4.90x4.80x1.12MM, 1.27P

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